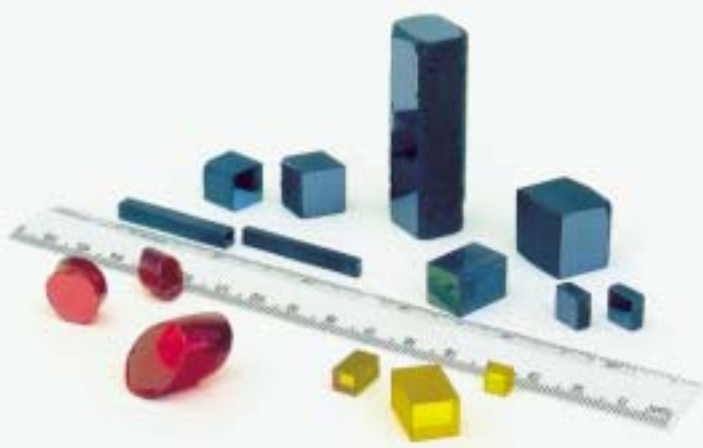


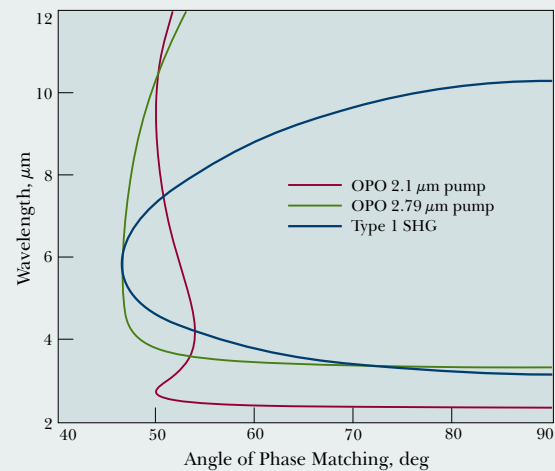
# Infrared Nonlinear Crystals



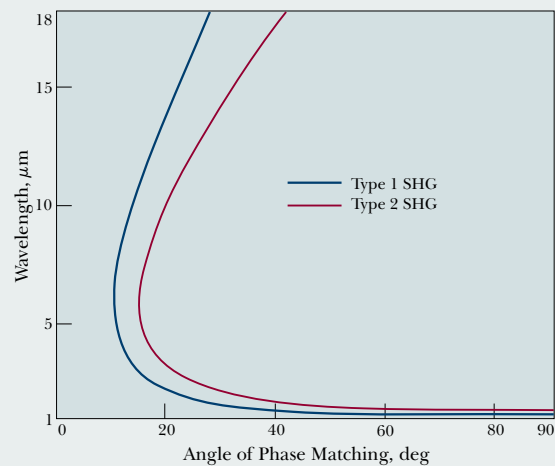
Optical nonlinear crystals like  $\text{ZnGeP}_2$ ,  $\text{AgGaSe}_2$ ,  $\text{AgGaS}_2$ ,  $\text{GaSe}$ ,  $\text{Tl}_3\text{AsSe}_3$  have gained tremendous interest for the middle and deep infrared applications due to their unique features. The crystals have large effective optical nonlinearity, wide spectral and angular acceptance, broad transparency range, noncritical requirements for temperature stabilisation and vibration control, are well mechanically processed (except of  $\text{GaSe}$  and  $\text{Tl}_3\text{AsSe}_3$ ).

$\text{ZnGeP}_2$  has band edges at 0.74 and 12  $\mu\text{m}$ . Its useful transmission range ( $\alpha < 0.3 \text{ cm}^{-1}$ ) lies from 2.1 to 10.6  $\mu\text{m}$ .  $\text{ZnGeP}_2$  has the largest nonlinear optical coefficient and relatively high laser damage threshold. It was successfully used in the following applications: up-conversion of  $\text{CO}_2$  laser light to near IR range<sup>(1)</sup> via mixing with 1.06 mm; sum frequency generation of CO and  $\text{CO}_2$  laser radiation<sup>(2)</sup>; efficient SHG of pulsed  $\text{CO}$ <sup>(3)</sup>,  $\text{CO}_2$ <sup>(4)</sup> (49% efficiency at 1  $\text{GW}/\text{cm}^2$  intensity of 2 ns pulses, 9.52 mm wavelength) and chemical DF-laser<sup>(5)</sup>, OPO light generation in mid infrared when pumped by erbium<sup>(6,7)</sup> and holmium<sup>(8)</sup> lasers.

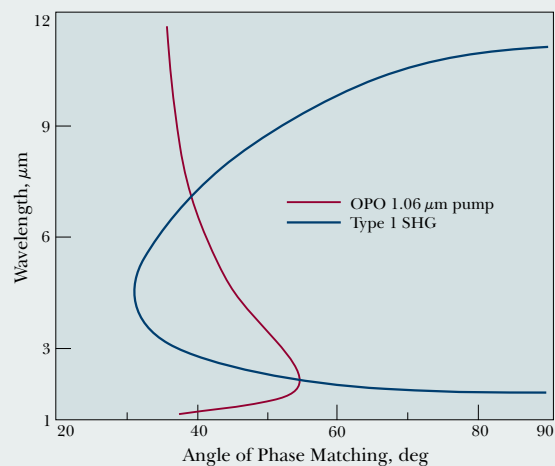
$\text{AgGaSe}_2$ <sup>(9)</sup> has band edges at 0.73 and 18  $\mu\text{m}$ . Its useful transmission range lying within 0.9–16  $\mu\text{m}$  and wide phase matchability provide excellent potential for OPO applications when pumped by variety of currently available lasers. Tuning within 2.5–12  $\mu\text{m}$  was obtained when pumped by Ho:YLF laser at 2.05  $\mu\text{m}$ <sup>(10)</sup>; NCPM operation within 1.9–5.5  $\mu\text{m}$  was achieved<sup>(11)</sup> pumping at 1.4–1.55  $\mu\text{m}$ . Efficient SHG of pulsed  $\text{CO}_2$  laser is demonstrated<sup>(12)</sup>.



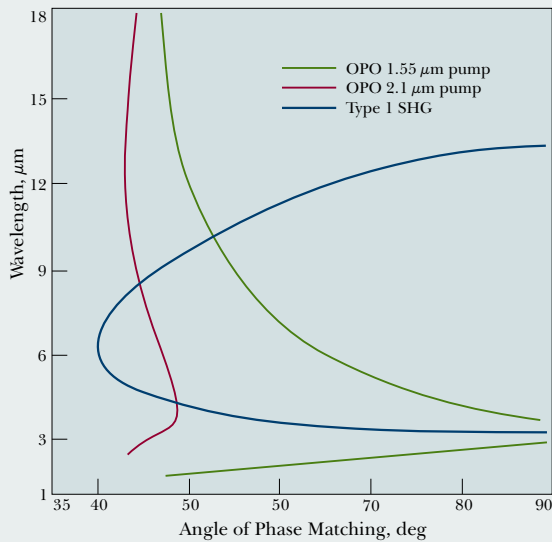
Type 1 OPO and SHG tuning curves in  $\text{ZnGeP}_2$



Type 1 and Type 2 SHG tuning curves in  $\text{GaSe}$



Type 1 OPO and SHG tuning curves in  $\text{AgGaS}_2$



Type 1 OPO and SHG tuning curves in AgGaSe<sub>2</sub>

AgGaSe<sub>2</sub> is transparent from 0.53 to 12 μm. Although nonlinear optical coefficient is the lowest among the above mentioned infrared crystals, its high short wavelength transparency edging at 550 nm is used in OPOs<sup>(13,14)</sup> pumped by Nd:YAG laser; in numerous difference frequency mixing experiments<sup>(15,16,17,18)</sup> using diode, Ti:Sapphire, Nd:YAG and IR dye lasers covering 3–12 μm range; direct infrared countermeasure systems, and SHG of CO<sub>2</sub> laser<sup>(19)</sup>.

GaSe has band edges at 0.65 and 18 μm. GaSe has been successfully used for efficient SHG of CO<sub>2</sub> laser<sup>(21)</sup> (up to 9% conversion); for SHG of pulsed CO, CO<sub>2</sub> and chemical DF-laser (λ = 2.36 μm) radiation<sup>(27)</sup>; upconversion of CO and CO<sub>2</sub> laser radiation into the visible range<sup>(20)</sup>; infrared pulses generation via difference frequency mixing of Neodymium and infrared dye laser<sup>(22,15)</sup> or (F<sup>-</sup>)-centre laser pulses<sup>(25)</sup>; OPG light generation within 3.5–18 μm<sup>(24)</sup>. It is impossible to cut crystals for certain phase matching angles because of material structure (cleave along (001) plane) limiting areas of applications.

### SELLMEIER EQUATIONS FOR CALCULATION OF INDICES OF REFRACTION

Crystal		A	B	C	D	E	F	Ref.	Expression
<b>ZnGeP<sub>2</sub></b>	n <sub>o</sub>	4.4733	5.26576	0.13381	1.49085	662.55	–	37	n <sup>2</sup> = A + B / (1 - C / λ <sup>2</sup> ) + D / (1 - E / λ <sup>2</sup> )
	n <sub>e</sub>	4.63318	5.34215	0.14255	1.45785	662.55	–		
<b>AgGaSe<sub>2</sub></b>	n <sub>o</sub>	6.8507	0.4297	0.15840	0.00125	–	–	36	n <sup>2</sup> = A + B / (λ <sup>2</sup> - C) - D λ <sup>2</sup>
	n <sub>e</sub>	6.6792	0.4598	0.21220	0.00126	–	–		
<b>AgGaS<sub>2</sub></b>	n <sub>o</sub>	3.3970	2.3982	0.09311	2.1640	950.0	–	13	n <sup>2</sup> = A + B / (1 - C / λ <sup>2</sup> ) + D / (1 - E / λ <sup>2</sup> )
	n <sub>e</sub>	3.5873	1.9533	0.11066	2.3391	1030.7	–		
<b>GaSe</b>	n <sub>o</sub>	7.443	0.405	0.0186	0.0061	3.1485	2194	4	n <sup>2</sup> = A + B/λ <sup>2</sup> + C/λ <sup>4</sup> + D/λ <sup>6</sup> + E/(1 - F/λ <sup>2</sup> )
	n <sub>e</sub>		5.76	0.3879	-0.2288	0.1223	1.855		
<b>Tl<sub>3</sub>AsSe<sub>3</sub></b>	n <sub>o</sub>	1	10.21	0.444	0.522	25	–		n <sup>2</sup> = A + B / (1 - C / λ <sup>2</sup> ) + D / (1 - E / λ <sup>2</sup> )
	n <sub>e</sub>	1	8.993	0.444	0.308	25	–		

Please contact EK SMA for further information or nonstandard specifications.

## Properties of ZnGeP<sub>2</sub>, AgGaSe<sub>2</sub>, AgGaS<sub>2</sub>, GaSe, Tl<sub>3</sub>AsSe<sub>3</sub>

		ZnGeP <sub>2</sub>	AgGaSe <sub>2</sub>	AgGaS <sub>2</sub>	GaSe	Tl <sub>3</sub> AsSe <sub>3</sub>
<b>CRYSTAL DATA</b>						
Crystal Symmetry		Tetragonal	Tetragonal	Tetragonal	Hexagonal	Trigonal
Point Group		42m	42m	42m	62m	R3m
Lattice Constants, Å	a	5.465	5.9901	5.757	3.742	9.80
	c	10.771	10.8823	10.305	15.918	7.08
Density, g/cm <sup>3</sup>		4.175	5.71	4.56	5.03	7.83
<b>OPTICAL PROPERTIES</b>						
Optical transmission, μm		0.74 ÷ 12 <sup>(23)</sup>	0.73 ÷ 18 <sup>(9)</sup>	0.53 ÷ 12 <sup>(32)</sup>	0.65 ÷ 18 <sup>(27)</sup>	1.23 ÷ 18 <sup>(39)</sup>
Indices of Refraction at						
1.06 μm	n <sub>o</sub>	3.2324	2.7005	2.4508	2.9082	
	n <sub>e</sub>	3.2786	2.6759	2.3966	2.5676	
5.3 μm	n <sub>o</sub>	3.1141	2.6140	2.3954	2.8340	3.357
	n <sub>e</sub>	3.1524	2.5823	2.3421	2.4599	3.171
10.6 μm	n <sub>o</sub>	3.0725	2.5915	2.3466	2.8158	3.331
	n <sub>e</sub>	3.1119	2.5585	2.2924	2.4392	3.152
Absorption Coefficient, cm <sup>-1</sup> at						
1.06 μm		3.0 <sup>(28)</sup>	<0.02 <sup>(9)</sup>	<0.09	0.25 <sup>(6)</sup>	
2.5 μm		0.2 <sup>(28)</sup>	<0.01	0.01	0.05 <sup>(6)</sup>	<0.2
5.0 μm		0.1 <sup>(28)</sup>	<0.01	0.01	0.05 <sup>(6)</sup>	<0.2
7.5 μm		0.1 <sup>(28)</sup>	-	0.02	0.05 <sup>(6)</sup>	<0.1
10.0 μm		0.3 <sup>(28)</sup>	-	<0.6	0.05 <sup>(6)</sup>	<0.1
11.0 μm		0.8 <sup>(28)</sup>	-	0.6	0.05 <sup>(6)</sup>	<0.1
<b>NONLINEAR OPTICAL PROPERTIES</b>						
Laser damage threshold, MW/cm <sup>2</sup>		60 <sup>(29)</sup>	25 <sup>(38)</sup>	10 <sup>(13)</sup>	28 <sup>(21)</sup>	10 <sup>(40)</sup>
at pulse duration, ns		100	50	20	150	70
at wavelength, μm		10.6	2.05	1.06	9.3	9.6
Nonlinearity, pm/V		111 <sup>(21)</sup>	43 <sup>(11)</sup>	31 <sup>(34)</sup>	63 <sup>(21)</sup>	46 <sup>(41)</sup>
Phase matching angle for Type 1 SHG at 10.6 μm, deg		76	55	67	14	12
Walk-off angle at 5.3 μm, deg		0.57 <sup>(21)</sup>	0.67 <sup>(11)</sup>	0.85 <sup>(19)</sup>	3.4 <sup>(21)</sup>	1.7
<b>THERMAL PROPERTIES</b>						
Melting point, °C		1298 <sup>(30)</sup>	851 <sup>(12)</sup>	998 <sup>(26)</sup>	1233	584 <sup>(77)</sup>
Thermal Expansion Coefficient, 10 <sup>-6</sup> /°K						
	⊥	17.5 <sup>(31,a)</sup>	23.4 <sup>(33,e)</sup>	12.5 <sup>(35)</sup>	9.0	
	⊥	9.1 <sup>(31,b)</sup>	18.0 <sup>(33,d)</sup>			
		1.59 <sup>(31,a)</sup>	-6.4 <sup>(33,e)</sup>	-13.2 <sup>(35)</sup>	8.25	
		8.08 <sup>(31,b)</sup>	-16.0 <sup>(33,d)</sup>			

a) at 293-573 K, b) at 573-873 K, c) at 298-423 K, d) at 423-873 K

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